

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/006,123	SHIEH ET AL.
	Examiner	Art Unit
	Joseph Lauture	2819

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
341	144	8/29/2005	JL
341	145	8/29/2005	JL